

Form 1449 (Modified)

**Information Disclosure
Statement By Applicant**

(Use Several Sheets if Necessary)

Atty Docket No.
ALPSP149/AB US02044-
Normal

Application No.:
10/802,649

Applicant:
Kitagawa

Filing Date
March 16, 2004

Group
2859

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
	A1	6,311,004	10/30/2001	Kenney, <i>et al.</i>	2		11/10/1999

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
<i>[Signature]</i>	B1	EP 0980018 A2	02/16/2000	EPO			X	
<i>[Signature]</i>	B2	2000029079	01/28/2000	EPO			X	

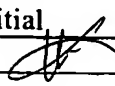
Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
<i>[Signature]</i>	C1	Ulrich Grusemann, <i>et al.</i> "Integrated-Optical Wavelength Sensor With Self-Compensation Of Thermally Induced Phase Shifts By Use Of A LiNbO3 Unbalanced Mach-Zehnder Interferometer" Applied Optics, Vol. 41, No. 29, October 10, 2002, Pages 6211-6219, XP 002290429, 2002
Examiner	<i>[Signature]</i>	Date Considered 1/28/05



Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form 1449 (Modified) Information Disclosure Statement By Applicant (Use Several Sheets if Necessary)	Atty Docket No.	Application No.:
	ALPSP149	Unassigned
	Applicant:	
	Hitoshi KITAGAWA	
Filing Date	Group	
Herewith	Unassigned	


U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
	A	6,643,431 B2	11/04/03	Hatayama et al.			
	B						
	C						
	D						
	E						
	F						
	G						
	H						
	I						

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
	J	7-181087	07/18/95	Japan				
	K	2000-29079	01/28/00	Japan				
	L							
	M							
	N							

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	O	
	P	
	Q	
Examiner 	Date Considered 7/28/05	

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.